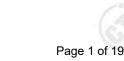
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Report	t No. : EED320	2807348	



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Product Trade mark Model/Type reference Serial Number Ratings Report Number Date of Issue Regulations	 BeagleY-AI BeagleY-AI BeagleY-AI N/A DC 5V/3A EED32Q807348 Jun. 14, 2024 See below 	8 8	
Test Standards		Results	
☑ 47 CFR FCC Part 15 Subpart B		PASS	6)

9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C

Prepared by:

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Date of Issue:
Jun. 14, 2024
Aron Ma
Date of Issue:
Jun. 14, 2024
Check No: 9553300524





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1. GENERAL INFORMATION

	IATION
Applicant:	Seeed Technology Co., Ltd
	9F, G3 Building, TCL International E City, Zhongshanyuan
	Road, Nanshan District, Shenzhen, Guangdong Province,
	P.R.C
Manufacturer:	Seeed Technology Co., Ltd
	9F, G3 Building, TCL International E City, Zhongshanyuan
	Road, Nanshan District, Shenzhen, Guangdong Province,
	P.R.C
Product:	BeagleY-AI
Trade mark:	💭 beagleboard.org®
Model/Type reference:	BeagleY-Al
Serial Number:	N/A
Report Number:	EED32Q807348
State of Sample(s):	Normal
Sample Received Date:	Jun. 03, 2024
Sample tested Date:	Jun. 03, 2024 to Jun. 06, 2024
Company Name and Addres	ss shown on Report, the sample(s) and sample Information
was/ were provided by the a	policant who should be responsible for the authenticity which

was/ were provided by the applicant who should be responsible for the authenticity which CTI hasn't verified.

2. TEST SUMMARY

The Product has been tested according to the following specifications:

Standard	Test Item	Test Method	Test
FCC 15.107	Conducted Emission	ANSI C63.4:2014	Yes
FCC 15.109	Radiated Emission	ANSI C63.4:2014	Yes

3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

	Test item	Value (dB)		
С	onducted disturbance	3.1	U	
Radiated	disturbance (30MHz to 1GHz)	4.9		
Radiated disturbance (1GHz to 6GHz)		4.7	S	
()	A) (A)	6	*)	





4. PRODUCT INFORMATION AND TEST SETUP

4.1. PRODUCT INFORMATION

Ratings:

2.4GHz:

DC 5V/3A

less than 1.705 MHz, the measurement shall only be made up to 30MHz.

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generated or used in the between 1.705 MHz and 108 MHz, the measurement

device or on which the

device operates or

Highest frequency

- tunes of the EUT is
- shall only be made up to 1 GHz.
 between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.
- between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.

 \boxtimes above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 40 GHz, whichever is lower.

4.2. TEST SETUP CONFIGURATION

See test photographs attached in Appendix 1 for the actual connections between Product and support equipment.

4.3. TEST MODE DESCRIPTION

Test Mode	Test Status
Normal	EUT powered and connected AE then it works normally.

No.	Device Type	Brand	Series No.	Model	Provider	Power Cord
1	Mobile phone	HUAWEI	H4D9XB13C26	HUAWEI	СТІ	6
		HUAVLI	15181	Y325-T00	CH	
2	Monitor	Philips	328P6VU	AU5221900059 398B	CTI	<u>(</u>)-
3	Adaptor	Salcomp		A2244	Applicant	

4.4. SUPPORT EQUIPMENT

Notes:

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

5. FACILITIES AND ACCREDITATIONS

5.1. TEST FACILITY

All test facilities used to collect the test data are located at Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4, CISPR 16-1-1 and other equivalent



standards.

5.2. TEST EQUIPMENT LIST

Instrumentation: The following list contains equipments used at CTI for testing. The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.

Equipment used during the tests:

Shielding Room No. 3_Hongwei-Conducted emissions							
Equipment	Equipment Manufacturer Model Series No. Due						
Receiver	R&S	ESCI	100435	04/17/2025			
LISN	R&S	ENV216	100098	09/21/2024			

- 1 ·	1.4.5	N	- A N		1.6.	1		
	3M Semi-a	nechoic Chamber	<u>(2)_Ho</u> i	ngwei-Radia	ted emiss	ions		
E	quipment	Manufacturer		Nodel	Series	No.	Due Date	
	DG Broadband Antenna	Schwarzbeck	VU	LB9163	9163-401		09/22/2024	
-	Chamber & sory Equipment	TDK	5	SAC-3	/		01/12/2027	
Microw	ave Preamplifier	Tonscend	EMC	051845SE	98038	30	12/13/2024	
Ho	orn Antenna	Schwarzbeck	BBH	IA 9120D	9120D-1	869	04/15/2025	
	Receiver	R&S	\bigcirc	ESR7	10169	97	09/21/2024	
		Measu	iring sof	ftware				
No.	Test site	Software na	me	Manufacturer So		Soft	ware version	
1 🔇	2#RE	EZ		Farad Tec	hnology	EM	IEC-3A1-Pre	
2	CE	EZ		Farad Teo	hnology	EM	C-CON 3A1.1	

5.3. LABORATORY ACCREDITATIONS AND LISTINGS

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable under the ISO/IEC 17025 to international or national standards. Equipment has been calibrated by accredited calibration laboratories.

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6. CONDUCTED EMISSION TEST

6.1. LIMITS

S)	Limits for Class B digital d	evices		
Frequency range	Limits dB(µV)			
(MHz)	Quasi-peak	Average		
0,15 to 0,50	66 to 56	56 to 46		
0,50 to 5	56	46		
5 to 30	60	50		

NOTE: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 to 0.50 MHz.

6.2. BLOCK DIAGRAM OF TEST SETUP

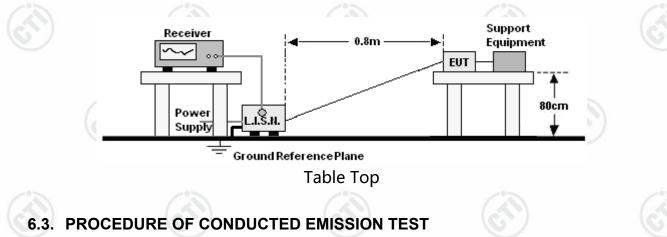


Table Top:

a. The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).

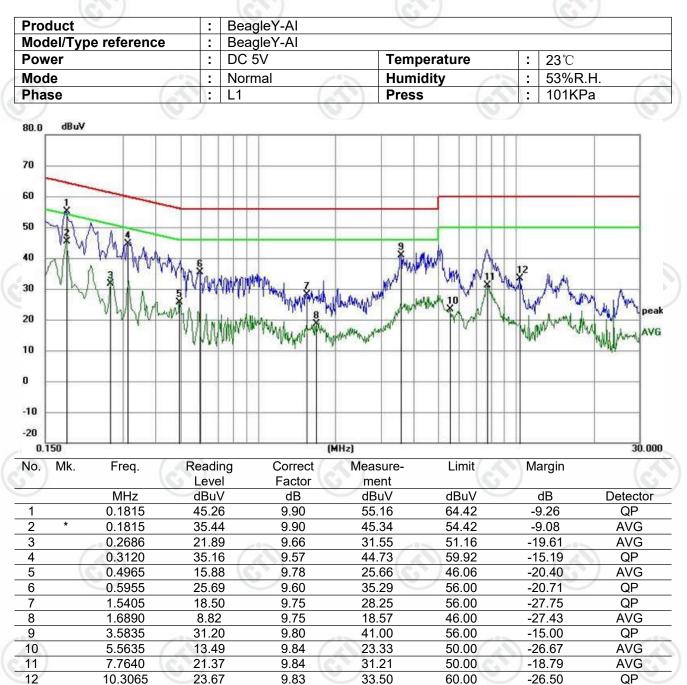
b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.

c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.





6.4. GRAPHS AND DATA



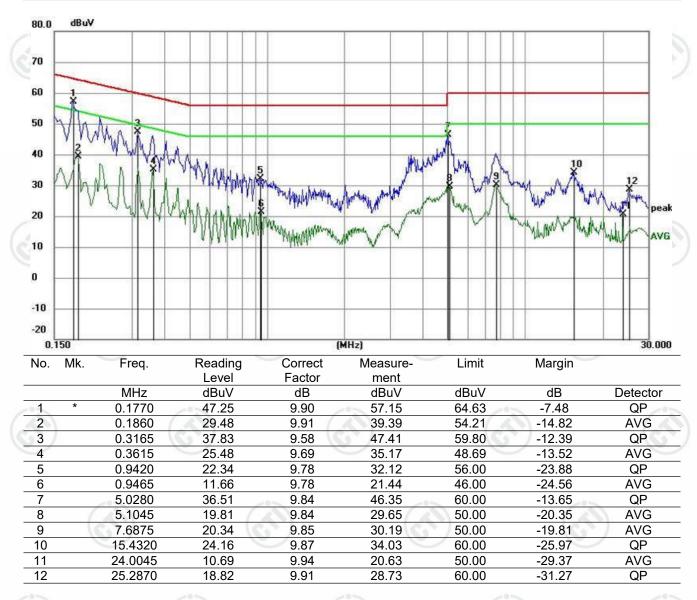




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Report No. : EED32Q807348

Product	:	BeagleY-Al			
Model/Type reference	:	BeagleY-Al			197
Power	:	DC 5V	Temperature	:	23 ℃
Mode	:	Normal	Humidity	:	53%R.H.
Phase	:	N	Press	:	101KPa



Note:

- 1. Margin=Measurement-Limit.
- 2. Measurement=Reading Level+Correct Factor.





Report No. : EED32Q807348



7. RADIATED EMISSION TEST 7.1. LIMITS

For unintentional device, according to §15.109 (a) Except for Class A digital devices, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values.

And according to §15.109 (2)measurements below 1000 MHz provided the limits in paragraphs (a) and (b) of this section are extrapolated to the new measurement distance using an inverse linear distance extrapolation factor (20 dB/decade).

According to FCC 15.31 section(1), at frequencies at or above 30 MHz measurements at a distance other than that specified, the results shall be extrapolated to the specified distance using an extrapolation factor of 20 dB/decade (inverse linear-distance for field strength measurements; inverse-linear-distance-squared for power density measurements).

According to FCC 15.31 section(2), frequencies below 30 MHz, performing measurements at a closer distance than specified, the results shall be extrapolated to the specified distance by either making measurements at a minimum of two distances on at least one radial to determine the proper extrapolation factor or by using the square of an inverse linear distance extrapolation factor (40 dB/decade).

According to 15.35 Measurement detector functions and bandwidths section (b). Unless otherwise specified, e.g., see §§15.250, 15.252, 15.253(d), 15.255, 15.256, and 15.509 through 15.519 of this part, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency (MHz)	limits at 3m dB(μV/m)
30-88	40.0
88-216	43.5
216-960	46.0
Above 960	54.0

Limits for Class B digital devices

NOTE: 1. The lower limit shall apply at the transition frequency.

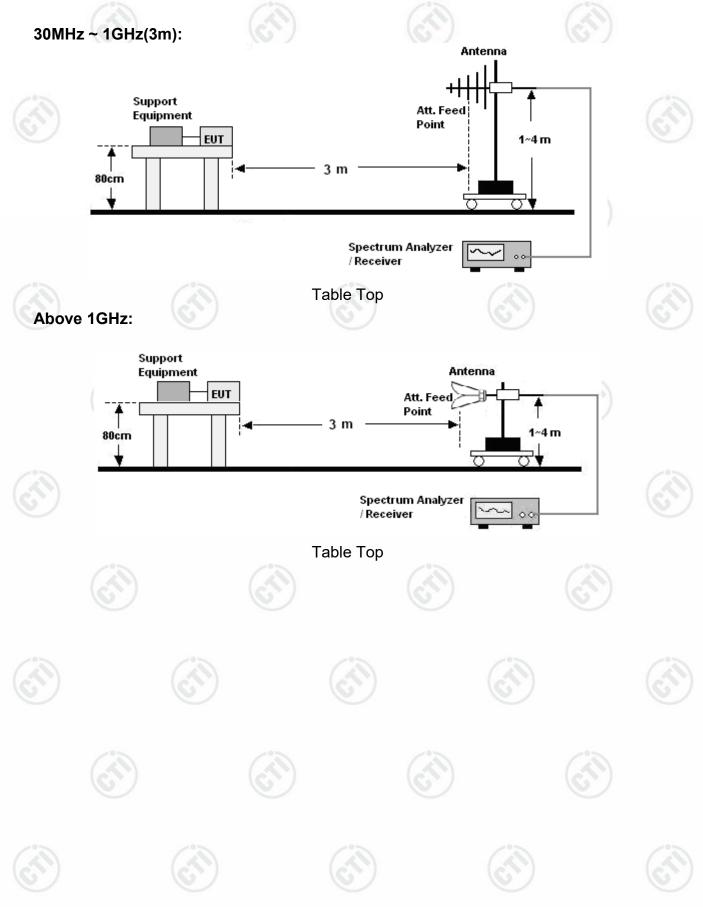
The limits shown above are based on measuring equipment employing a CISPR quasi-peak detector function for frequencies below or equal to 1000MHz.
 The limits shown above are based on measuring equipment employing an average

detector function for frequencies above 1000MHz.





7.2. BLOCK DIAGRAM OF TEST SETUP



Hotline:400-6788-333 www.cti-cert.com E-mail:info@cti-cert.com Complaint call:0755-33681700 Complaint E-mail:complaint@cti-cert.com



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7.3. PROCEDURE OF RADIATED EMISSION TEST

30MHz ~ 1GHz(Table Top):

a. The Product was placed on the non-conductive turntable 0.8m above the ground at a chamber.

b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

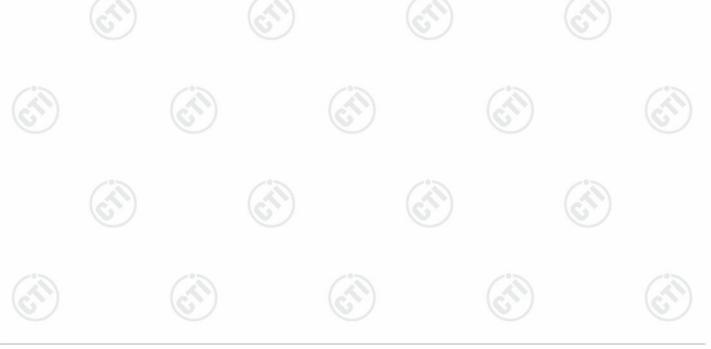
c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz(Table Top):

a. The Product was placed on the non-conductive turntable 0.8m above the ground at a chamber.

b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.

c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.







7.4. GRAPHS AND DATA

12

1949.921

53.06

-11.64

Product	:	BeagleY	′-AI	0	1		0	
Model/Type referenc	e :	BeagleY						
Power	:	DC 5V		Temper	ature	: 25	5°C	
Mode	:	Normal		Humidity				
Polarization		Horizont		Press			101KPa	
Fuldrization		TIONZON	lai	FIESS	- (πγ	6
82.0 dBuV/m			103		1	N N		
72						_	<u>.</u>	
52								
52			3	3			5	6
2 2		12	8 Junitaria	June	in theman			ě
· AAAI	1	, a th	MW 1	Magnet	New	Contraction Land	alexandras	n pea
B2 A A	1 A. M.A.	and No	and moren 1	My I	www.hunn	malana [470
" MMMM	W W W	IM	NNW	when	10	VI	doctor had had	AVE
	Aduth	Without V						1555
N.								
12							- 197	
2								
8								
18								
1000.000		224	(MHz)	18 a.		4000	12	6000.
No. Mk. Freq.	Reading Level	Correct Factor	Measurement	Limit		argin	Antenna Height	Table Degree
MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree
1 2250.045	58.35	-9.74	48.61	74.00	-25.39	peak	199	32
2 1199.988	59.97	-17.28	42.69	74.00	-31.31	peak	100	126
3 2692.298	55.19	-7.51	47.68	74.00	-26.32	peak	199	82
4 3750.094	50.82	-3.52	47.30	74.00	-26.70	peak	100	41
5 4978.149	49.63	-0.34	49.29	74.00	-24.71	peak	100	24
6 5747.970	45.21	1.44	46.65	74.00	-27.35	peak	199	0
7 1199.988	52.58	-17.28	35.30	54.00	-18.70	AVG	100	126
8 2099.875	52.71	-10.65	42.06	54.00	-11.94	AVG	100	345
9 * 2249.844	57.35	-9.75	47.60	54.00	-6.40	AVG	199	49
10 3750.094	44.97	-3.52	41.45	54.00	-12.55	AVG	100	41
11 2550.029	51.32	-8.04	43.28	54.00	-10.72	AVG	100	41
	50.00	44.04		E 4 00	40.50		400	110



41.42

54.00

-12.58

AVG

100

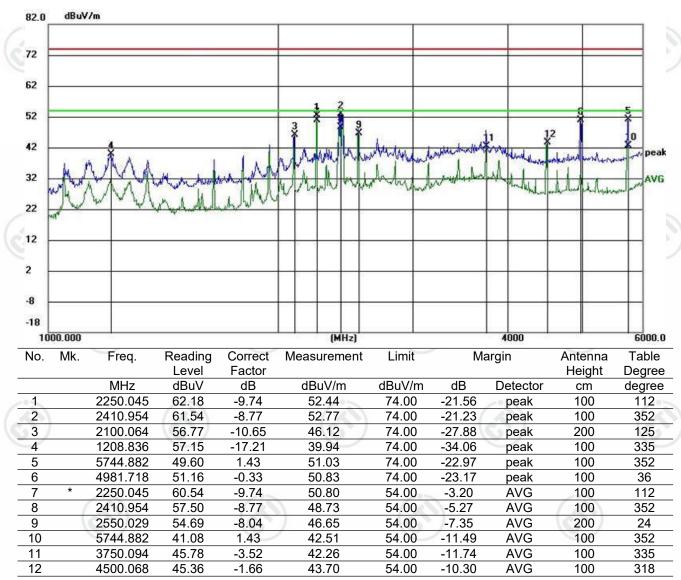
143





Report No. : EED32Q807348

Product	:	BeagleY-AI			
Model/Type reference	:	BeagleY-Al	10		100
Power	:	DC 5V	Temperature	:	25 ℃
Mode	:	Normal	Humidity	:	53%R.H.
Polarization	:	Vertical	Press	:	101KPa











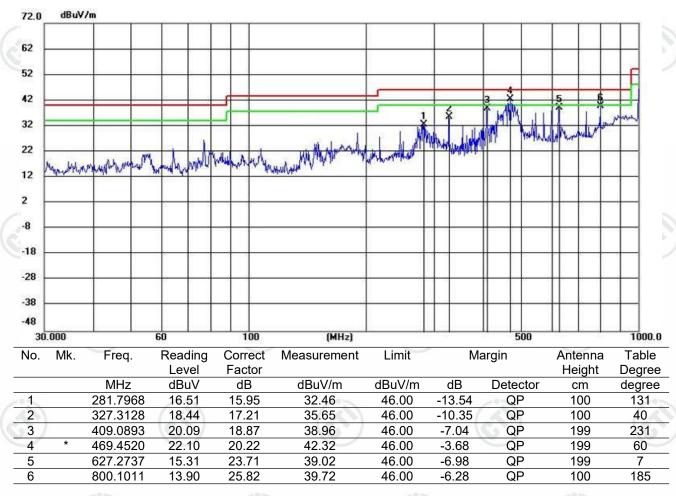






Report No. : EED32Q807348

Product	:	BeagleY-Al			
Model/Type reference	:	BeagleY-Al	107		100
Power	:	DC 5V	Temperature	:	25 ℃
Mode	:	Normal	Humidity	:	53%R.H.
Polarization	:	Horizontal	Press	:	101KPa



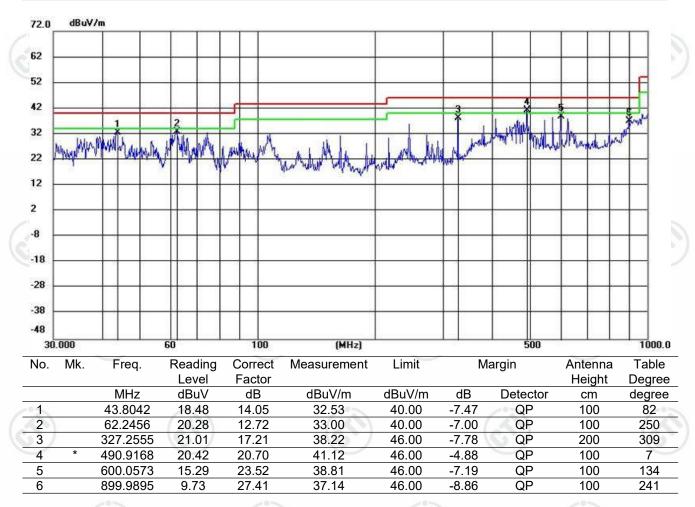




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Report No. : EED32Q807348

Product	:	BeagleY-Al			
Model/Type reference	:	BeagleY-Al			100
Power	:	DC 5V	Temperature	:	25 ℃
Mode	:	Normal	Humidity	:	53%R.H.
Polarization	:	Vertical	Press	:	101KPa



Note:

1. Margin=Measurement-Limit.

2. Measurement=Reading Level+Correct Factor.









APPENDIX 1 PHOTOGRAPHS OF TEST SETUP



Conducted emissions Test Setup-1



Radiated emissions Test Setup-1













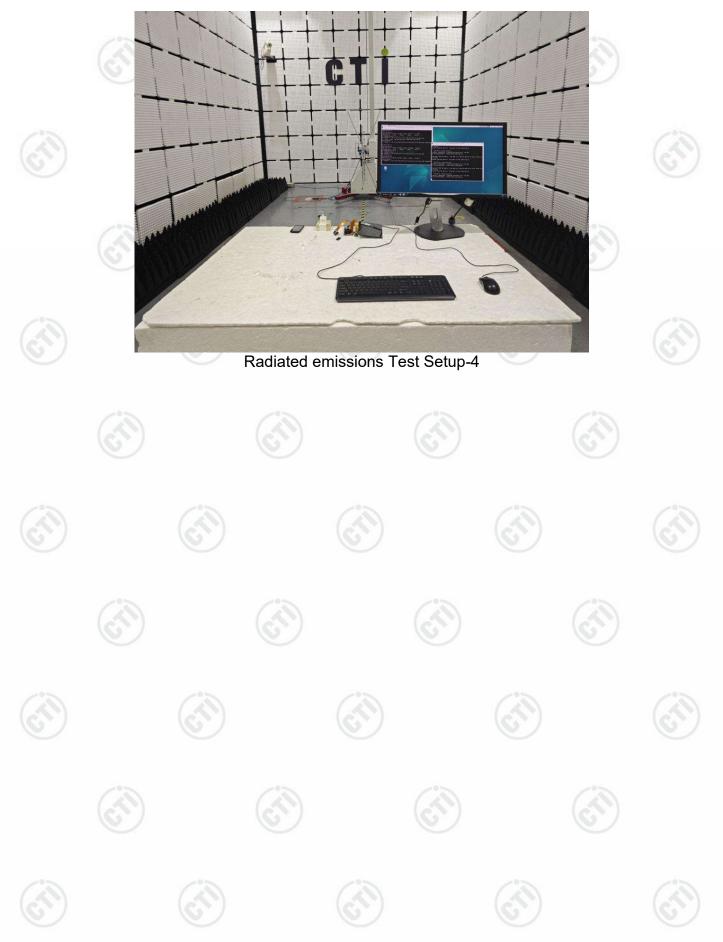








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APPENDIX 2 PHOTOGRAPHS OF PRODUCT

